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Kind regards,

Team Nexperia

Product data sheet

Product profile

1.1 General description

N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology.

1.2 Features

- Low thermal resistance
- Low threshold voltage
- SO8 equivalent area footprint
- Low on-state resistance

1.3 Applications

- DC-to-DC converters
- Portable appliances
- DC motor drives

- Switched-mode power supplies
- Notebook computers

1.4 Quick reference data

- $V_{DS} \le 40 \text{ V}$
- \blacksquare R_{DSon} \leq 4.1 m Ω

- $I_D \le 94.5 \text{ A}$
- Arr P_{tot} \leq 62.5 W

Pinning information

Table 1. **Pinning**

| Pin | Description | Simplified outline | Symbol |
|---------|---------------------------------------|--------------------|----------|
| 1, 2, 3 | source (S) | | _ |
| 4 | gate (G) | mb | D |
| mb | mounting base; connected to drain (D) | 1 2 3 4 | mbb076 S |
| | | SOT669 (LFPAK) | |



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3. Ordering information

Table 2. Ordering information

| Type number | Package | | |
|-------------|---------|---|---------|
| | Name | Description | Version |
| PH4840S | LFPAK | plastic single-ended surface-mounted package; 4 leads | SOT669 |

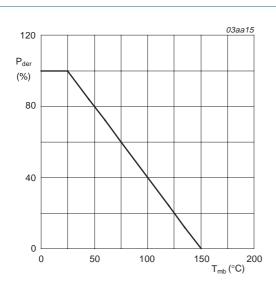
4. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

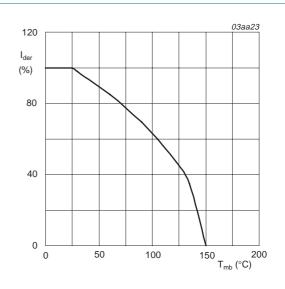
| Symbol | Parameter | Conditions | Min | Max | Unit |
|----------------------|--|--|-----|------|------|
| V_{DS} | drain-source voltage | 25 °C ≤ T _j ≤ 150 °C | - | 40 | V |
| V_{GS} | gate-source voltage | | - | ±20 | V |
| I _D | drain current | T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 2</u> and <u>3</u> | - | 94.5 | Α |
| | | T_{mb} = 100 °C; V_{GS} = 10 V; see <u>Figure 2</u> | - | 59.5 | Α |
| I_{DM} | peak drain current | T_{mb} = 25 °C; pulsed; $t_p \le 10 \mu s$; see Figure 3 | - | 283 | Α |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see <u>Figure 1</u> | - | 62.5 | W |
| T _{stg} | storage temperature | | -55 | +150 | °C |
| Tj | junction temperature | | -55 | +150 | °C |
| Source-c | Irain diode | | | | |
| Is | source current | T _{mb} = 25 °C | - | 52 | Α |
| I _{SM} | peak source current | T_{mb} = 25 °C; pulsed; $t_p \le 10 \mu s$ | - | 150 | Α |
| Avalanch | ne ruggedness | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | unclamped inductive load; I_D = 51 A; t_p = 0.21 ms; $V_{DS} \le$ 40 V; V_{GS} = 10 V; starting at T_j = 25 °C | - | 250 | mJ |

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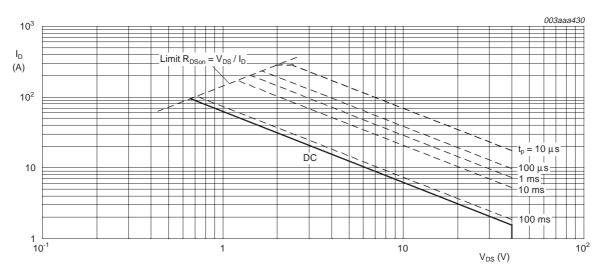
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

Fig 1. Normalized total power dissipation as a function of mounting base temperature



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100 \%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature



 T_{mb} = 25 °C; I_{DM} is single pulse; V_{GS} = 10 V

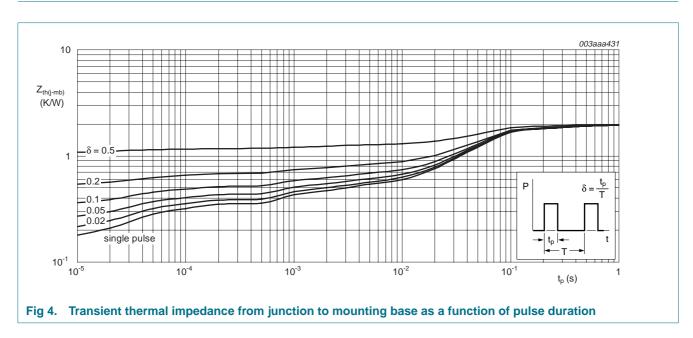
Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

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5. Thermal characteristics

Table 4. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------|---|--------------|-----|-----|-----|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | see Figure 4 | - | - | 2 | K/W |



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6. Characteristics

Table 5. Characteristics

 $T_j = 25 \,^{\circ}C$ unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------------|--------------------------------|---|-----|------|-----|-----------|
| Static ch | Static characteristics | | | | | |
| V _{(BR)DSS} | drain-source breakdown voltage | $I_D = 250 \mu A; V_{GS} = 0 V$ | 40 | - | - | V |
| V _{GS(th)} | gate-source threshold voltage | $I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; see Figure 9 and 10 | | | | |
| | | T _j = 25 °C | 1 | 2 | 3 | V |
| | | T _j = 150 °C | 0.5 | - | - | V |
| | | T _j = −55 °C | - | - | 2.2 | V |
| I _{DSS} | drain leakage current | $V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}$ | | | | |
| | | T _j = 25 °C | - | 0.06 | 1 | μΑ |
| | | T _j = 150 °C | - | - | 500 | μΑ |
| I _{GSS} | gate leakage current | $V_{GS} = \pm 20 \text{ V}; V_{DS} = 0 \text{ V}$ | - | 2 | 100 | nΑ |
| R _{DSon} | drain-source on-state | $V_{GS} = 10 \text{ V}$; $I_D = 25 \text{ A}$; see Figure 6 and 8 | | | | |
| | resistance | T _j = 25 °C | - | 3.5 | 4.1 | $m\Omega$ |
| | | T _j = 150 °C | - | 5.6 | 7.0 | $m\Omega$ |
| | | $V_{GS} = 7 \text{ V}$; $I_D = 25 \text{ A}$; see Figure 6 and 8 | - | 3.85 | 4.8 | $m\Omega$ |
| Dynamic | characteristics | | | | | |
| Q _{G(tot)} | total gate charge | $I_D = 30 \text{ A}; V_{DS} = 32 \text{ V}; V_{GS} = 10 \text{ V};$ see Figure 11 and 12 | - | 67 | - | nC |
| Q_{GS} | gate-source charge | | - | 8.6 | - | nC |
| Q_{GD} | gate-drain charge | | - | 16 | - | nC |
| C _{iss} | input capacitance | $V_{GS} = 0 \text{ V}; V_{DS} = 10 \text{ V}; f = 1 \text{ MHz};$ | - | 3660 | - | pF |
| Coss | output capacitance | see Figure 14 | - | 877 | - | pF |
| C_{rss} | reverse transfer capacitance | | - | 454 | - | pF |
| t _{d(on)} | turn-on delay time | V_{DS} = 20 V; I_{D} = 25 Ω ; V_{GS} = 10 V; | - | 21 | - | ns |
| t _r | rise time | $R_G = 4.7 \Omega$ | - | 35 | - | ns |
| $t_{d(off)}$ | turn-off delay time | | - | 82 | - | ns |
| t _f | fall time | | - | 31 | - | ns |
| Source- | drain diode | | | | | |
| V_{SD} | source-drain voltage | $I_S = 25 \text{ A}$; $V_{GS} = 0 \text{ V}$; see <u>Figure 13</u> | - | 0.85 | 1.2 | V |
| t _{rr} | reverse recovery time | $I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V}$ | - | 46 | - | ns |
| | | | | | | |

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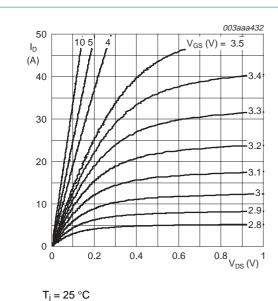
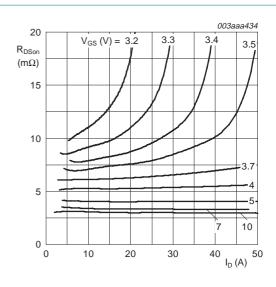
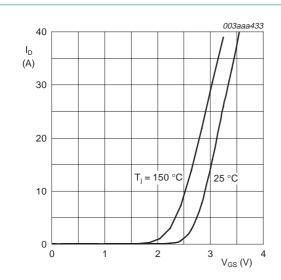


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



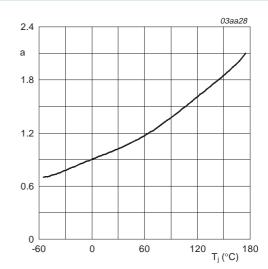
T_i = 25 °C

Fig 6. Drain-source on-state resistance as a function of drain current; typical values



 $T_i = 25$ °C and 150 °C; $V_{DS} > I_D \times R_{DSon}$





$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature

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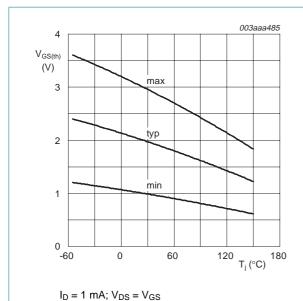
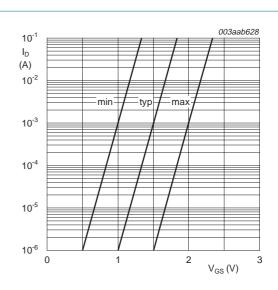


Fig 9. Gate-source threshold voltage as a function of junction temperature



 $T_j = 25~^{\circ}C;~V_{DS} = 5~V$

Fig 10. Sub-threshold drain current as a function of gate-source voltage

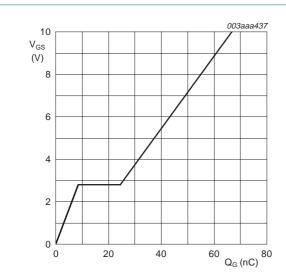


Fig 11. Gate-source voltage as a function of gate charge; typical values

 $I_D = 30 A; V_{DS} = 32 V$

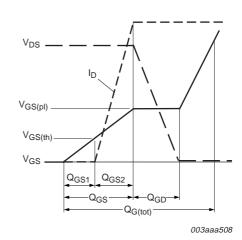
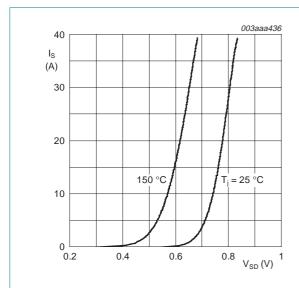


Fig 12. Gate charge waveform definitions

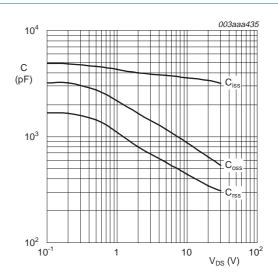
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 T_j = 25 °C and 150 °C; V_{GS} = 0 V

Fig 13. Source current as a function of source-drain voltage; typical values



 $V_{GS} = 0 V$; f = 1 MHz

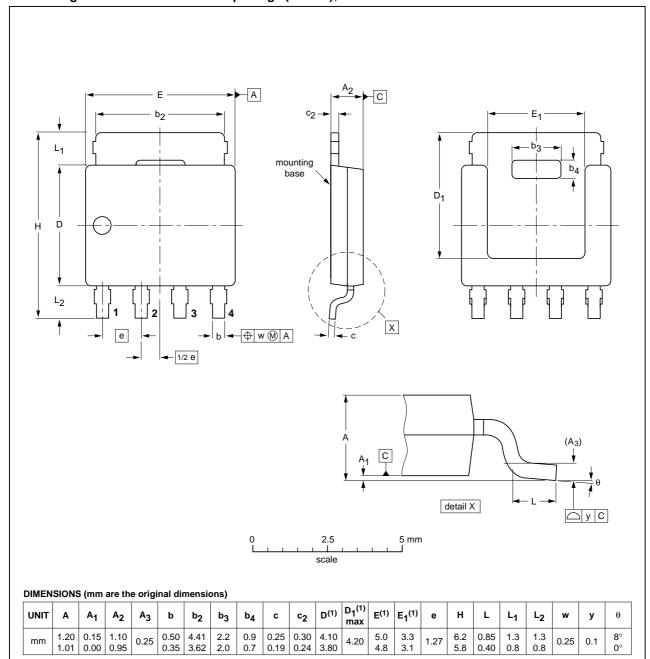
Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

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7. Package outline

Plastic single-ended surface-mounted package (LFPAK); 4 leads

SOT669



Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

| OUTLINE | | REFER | ENCES | | EUROPEAN PROJECTION | ISSUE DATE |
|---------|-----|--------|-------|--|------------------------|---------------------------------|
| VERSION | IEC | JEDEC | JEITA | | | ISSUE DATE |
| SOT669 | | MO-235 | | | | 04-10-13 06-03-16 |

Fig 15. Package outline SOT669 (LFPAK)

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8. Revision history

Table 6. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|--------------------------------|---|---------------------------|--------------------|------------------|
| PH4840S_2 | 20061106 | Product data sheet | - | PH4840S-01 |
| Modifications: | The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. | | | |
| | Legal texts ha | ive been adapted to the n | ew company name wh | ere appropriate. |
| PH4840S-01 (9397 750 12814) | 20040304 | Preliminary data | - | - |

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9. Legal information

9.1 Data sheet status

| Document status[1][2] | Product status[3] | Definition |
|--------------------------------|-------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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